Searcn Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/537,386	RIED ET AL.	
Examiner	Art Unit	
Ahshik Kim	2876	

SEARCHED					
Class	Subclass	Date	Examiner		
235	492	4/10/2007	AK		
	451				
	488				
361	736				
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343	866	,	/		
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INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
above	9/26/2007	AK			
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	Subclass	Subclass Date			

SEARCH NO	TES STRATEGY)
	DATE	EXMR
See attached EAST search history	4/10/2007	AK
Updated search	9/26/2007	AK